

Acta Crystallographica Section E

## Structure Reports

Online

ISSN 1600-5368

## 1,4-Dibromo-2,5-dimethoxybenzene

Zhong-Hua Luo, Jin Chang, Mei-Li Feng, Qin Zhang and Hong-Jun Zhu\*

Department of Applied Chemistry, College of Science, Nanjing University of Technology, Nanjing 210009, People's Republic of China

Correspondence e-mail: zhuhj@njut.edu.cn

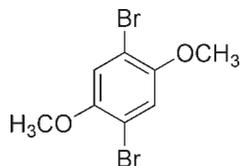
Received 17 May 2010; accepted 17 June 2010

Key indicators: single-crystal X-ray study;  $T = 298$  K; mean  $\sigma(\text{C}-\text{C}) = 0.008$  Å;  $R$  factor = 0.044;  $wR$  factor = 0.102; data-to-parameter ratio = 16.1.

The asymmetric unit of the title compound,  $\text{C}_8\text{H}_8\text{Br}_2\text{O}_2$ , contains one half-molecule, the complete molecule being generated by inversion symmetry.

## Related literature

For standard bond lengths, see: Allen *et al.* (1987). For the synthetic procedure, see: Lopez-Alvarado *et al.* (2002). For potential uses of compounds derived from the title compound, see: Chen *et al.* (2006).



## Experimental

## Crystal data

$\text{C}_8\text{H}_8\text{Br}_2\text{O}_2$   
 $M_r = 295.94$   
 Monoclinic,  $P2_1/n$

$a = 6.573$  (1) Å  
 $b = 8.438$  (2) Å  
 $c = 8.756$  (2) Å

$\beta = 90.14$  (3)°  
 $V = 485.6$  (2) Å<sup>3</sup>  
 $Z = 2$   
 Mo  $K\alpha$  radiation

$\mu = 8.30$  mm<sup>-1</sup>  
 $T = 298$  K  
 $0.20 \times 0.10 \times 0.10$  mm

## Data collection

Enraf–Nonius CAD-4 diffractometer  
 Absorption correction:  $\psi$  scan (North *et al.*, 1968)  
 $T_{\min} = 0.288$ ,  $T_{\max} = 0.491$   
 1761 measured reflections

884 independent reflections  
 622 reflections with  $I > 2\sigma(I)$   
 $R_{\text{int}} = 0.112$   
 3 standard reflections every 200 reflections  
 intensity decay: 1%

## Refinement

$R[F^2 > 2\sigma(F^2)] = 0.044$   
 $wR(F^2) = 0.102$   
 $S = 1.01$   
 884 reflections

55 parameters  
 H-atom parameters constrained  
 $\Delta\rho_{\text{max}} = 0.58$  e Å<sup>-3</sup>  
 $\Delta\rho_{\text{min}} = -0.41$  e Å<sup>-3</sup>

Data collection: *CAD-4 Software* (Enraf–Nonius, 1985); cell refinement: *CAD-4 Software*; data reduction: *XCAD4* (Harms & Wocadlo, 1995); program(s) used to solve structure: *SHELXS97* (Sheldrick, 2008); program(s) used to refine structure: *SHELXL97* (Sheldrick, 2008); molecular graphics: *SHELXTL* (Sheldrick, 2008); software used to prepare material for publication: *SHELXTL*.

The authors thank the Center of Testing and Analysis, Nanjing University, for support.

Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: IM2205).

## References

- Allen, F. H., Kennard, O., Watson, D. G., Brammer, L., Orpen, A. G. & Taylor, R. (1987). *J. Chem. Soc. Perkin Trans. 2*, pp. S1–19.  
 Chen, Z. K., Huang, C., Yang, J. S., O'Shea, S. & Loh, K. P. (2006). National University of Singapore, Singapore. WO patent number. 2006093467.  
 Enraf–Nonius (1985). *CAD-4 Software*. Enraf–Nonius, Delft, The Netherlands.  
 Harms, K. & Wocadlo, S. (1995). *XCAD4*. University of Marburg, Germany.  
 Lopez-Alvarado, P., Avendano, C. & Menendez, J. C. (2002). *Synthetic Commun.* **32**, 3233–3239.  
 North, A. C. T., Phillips, D. C. & Mathews, F. S. (1968). *Acta Cryst.* **A24**, 351–359.  
 Sheldrick, G. M. (2008). *Acta Cryst.* **A64**, 112–122.

## supporting information

*Acta Cryst.* (2010). E66, o1806 [doi:10.1107/S1600536810023548]

## 1,4-Dibromo-2,5-dimethoxybenzene

Zhong-Hua Luo, Jin Chang, Mei-Li Feng, Qin Zhang and Hong-Jun Zhu

### S1. Comment

The title compound, 1,4-dibromo-2,5-dimethoxybenzene is an important intermediate in the synthesis of 4-(2',5'-dimethoxy-4'-acetylthiophenyl)phenyl-nonafluorobiphenyl, which can be used as molecular switch, transistor and in the manufacture of memory devices (Chen *et al.*, 2006). We report here the crystal structure of the title compound, (I).

The molecular structure of (I) is shown in Fig. 1. Bond lengths and angles are within normal ranges (Allen *et al.*, 1987).

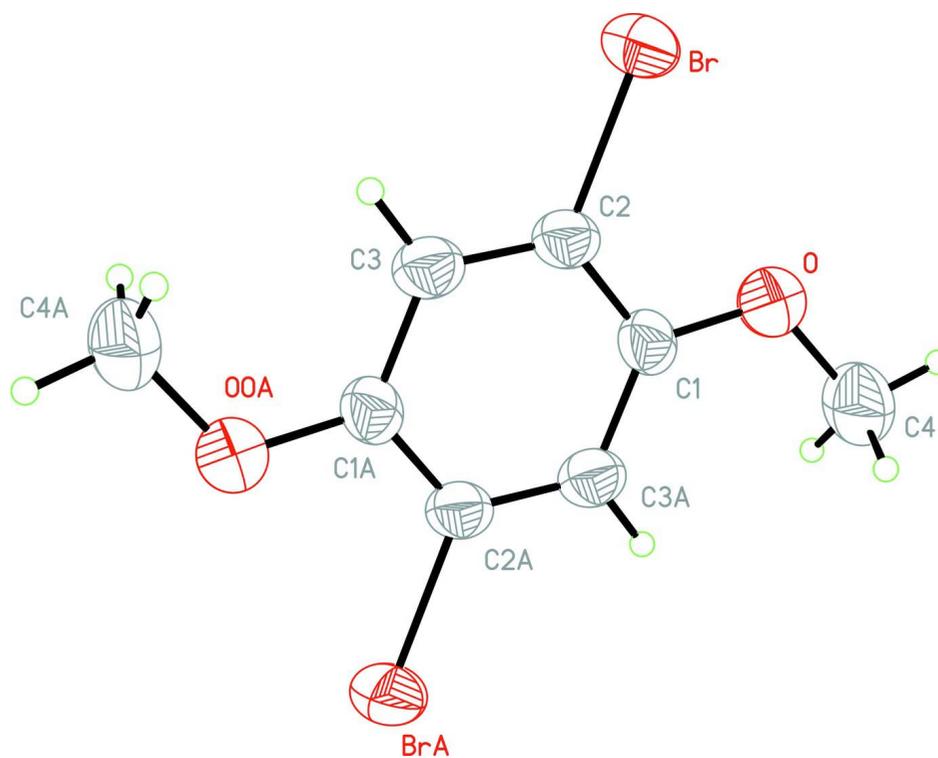
The benzene ring is planar and its center represents a crystallographic center of inversion. So only half of the molecule was observed in the asymmetric unit. No hydrogen bond interactions were observed in the crystal structure.

### S2. Experimental

The title compound, (I) was synthesized according to a literature method reported before (Lopez-Alvarado *et al.*, 2002). Single crystals were obtained by slow evaporation of a methanolic (25 ml) solution of the compound (0.30 g, 1.0 mmol) at room temperature for about 15 d.

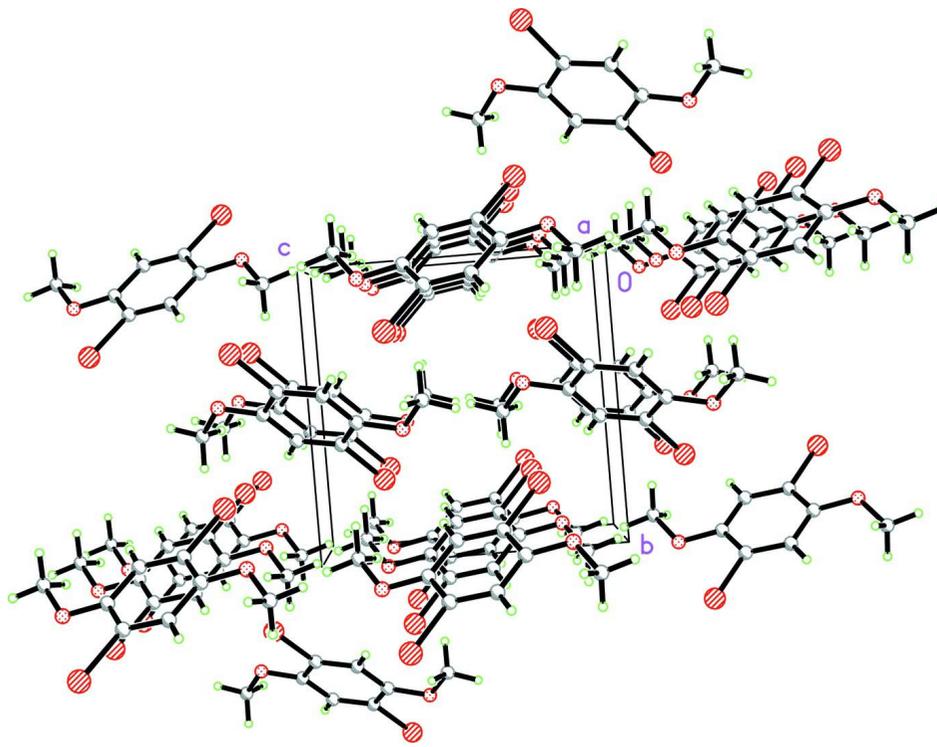
### S3. Refinement

H atoms were positioned geometrically, with C—H = 0.93 Å for aromatic H and 0.96 Å for methyl H, and constrained to ride on their parent atoms, with  $U_{\text{iso}}(\text{H}) = xU_{\text{eq}}(\text{C/O})$ , where  $x = 1.2$  for aromatic H and  $x = 1.5$  for other H.



**Figure 1**

Molecular structure of the title compound showing the atom-numbering scheme. Displacement ellipsoids are drawn at the 40% probability level.

**Figure 2**

Molecular packing of the title compound.

**1,4-Dibromo-2,5-dimethoxybenzene***Crystal data* $C_8H_8Br_2O_2$  $M_r = 295.94$ Monoclinic,  $P2_1/n$ Hall symbol:  $-P\ 2_1n$  $a = 6.573\ (1)\ \text{\AA}$  $b = 8.438\ (2)\ \text{\AA}$  $c = 8.756\ (2)\ \text{\AA}$  $\beta = 90.14\ (3)^\circ$  $V = 485.6\ (2)\ \text{\AA}^3$  $Z = 2$  $F(000) = 284$  $D_x = 2.024\ \text{Mg m}^{-3}$ Mo  $K\alpha$  radiation,  $\lambda = 0.71073\ \text{\AA}$ 

Cell parameters from 25 reflections

 $\theta = 9\text{--}13^\circ$  $\mu = 8.30\ \text{mm}^{-1}$  $T = 298\ \text{K}$ 

Block, colourless

 $0.20 \times 0.10 \times 0.10\ \text{mm}$ *Data collection*Enraf–Nonius CAD-4  
diffractometer

Radiation source: fine-focus sealed tube

Graphite monochromator

 $\omega/2\theta$  scansAbsorption correction:  $\psi$  scan  
(North *et al.*, 1968) $T_{\min} = 0.288$ ,  $T_{\max} = 0.491$ 

1761 measured reflections

884 independent reflections

622 reflections with  $I > 2\sigma(I)$  $R_{\text{int}} = 0.112$  $\theta_{\max} = 25.3^\circ$ ,  $\theta_{\min} = 3.4^\circ$  $h = -7 \rightarrow 7$  $k = -10 \rightarrow 0$  $l = -10 \rightarrow 10$ 

3 standard reflections every 200 reflections

intensity decay: 1%

Refinement

Refinement on  $F^2$   
 Least-squares matrix: full  
 $R[F^2 > 2\sigma(F^2)] = 0.044$   
 $wR(F^2) = 0.102$   
 $S = 1.01$   
 884 reflections  
 55 parameters  
 0 restraints  
 Primary atom site location: structure-invariant  
 direct methods

Secondary atom site location: difference Fourier  
 map  
 Hydrogen site location: inferred from  
 neighbouring sites  
 H-atom parameters constrained  
 $w = 1/[\sigma^2(F_o^2) + (0.03P)^2 + 0.0P]$   
 where  $P = (F_o^2 + 2F_c^2)/3$   
 $(\Delta/\sigma)_{\max} < 0.001$   
 $\Delta\rho_{\max} = 0.58 \text{ e } \text{Å}^{-3}$   
 $\Delta\rho_{\min} = -0.41 \text{ e } \text{Å}^{-3}$

Special details

**Geometry.** All e.s.d.'s (except the e.s.d. in the dihedral angle between two l.s. planes) are estimated using the full covariance matrix. The cell e.s.d.'s are taken into account individually in the estimation of e.s.d.'s in distances, angles and torsion angles; correlations between e.s.d.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell e.s.d.'s is used for estimating e.s.d.'s involving l.s. planes.

**Refinement.** Refinement of  $F^2$  against ALL reflections. The weighted  $R$ -factor  $wR$  and goodness of fit  $S$  are based on  $F^2$ , conventional  $R$ -factors  $R$  are based on  $F$ , with  $F$  set to zero for negative  $F^2$ . The threshold expression of  $F^2 > \sigma(F^2)$  is used only for calculating  $R$ -factors(gt) etc. and is not relevant to the choice of reflections for refinement.  $R$ -factors based on  $F^2$  are statistically about twice as large as those based on  $F$ , and  $R$ -factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters ( $\text{Å}^2$ )

	$x$	$y$	$z$	$U_{\text{iso}}^*/U_{\text{eq}}$
Br	0.26386 (11)	0.73471 (7)	0.78061 (8)	0.0598 (3)
O	-0.1091 (7)	0.5578 (5)	0.7000 (5)	0.0551 (11)
C1	-0.0605 (9)	0.5256 (6)	0.8479 (6)	0.0394 (13)
C2	0.1090 (9)	0.5986 (5)	0.9077 (7)	0.0400 (13)
C3	0.1721 (9)	0.5752 (5)	1.0558 (7)	0.0433 (14)
H3A	0.2881	0.6260	1.0922	0.052*
C4	-0.2593 (11)	0.4649 (8)	0.6294 (8)	0.0649 (19)
H4A	-0.2775	0.4993	0.5257	0.097*
H4B	-0.3852	0.4761	0.6837	0.097*
H4C	-0.2181	0.3558	0.6304	0.097*

Atomic displacement parameters ( $\text{Å}^2$ )

	$U^{11}$	$U^{22}$	$U^{33}$	$U^{12}$	$U^{13}$	$U^{23}$
Br	0.0762 (5)	0.0516 (4)	0.0517 (5)	-0.0207 (3)	0.0162 (3)	0.0026 (3)
O	0.065 (3)	0.055 (2)	0.045 (3)	-0.011 (2)	-0.004 (2)	0.0031 (19)
C1	0.049 (3)	0.036 (3)	0.033 (3)	0.002 (3)	0.007 (3)	-0.003 (2)
C2	0.047 (3)	0.031 (3)	0.042 (4)	-0.004 (3)	0.009 (3)	-0.002 (2)
C3	0.049 (3)	0.034 (3)	0.046 (4)	-0.006 (3)	0.007 (3)	-0.003 (2)
C4	0.070 (5)	0.078 (4)	0.047 (5)	-0.004 (4)	-0.014 (4)	0.009 (4)

Geometric parameters ( $\text{Å}$ ,  $^\circ$ )

Br—C2	1.897 (5)	C3—C1 <sup>i</sup>	1.405 (7)
O—C1	1.361 (7)	C3—H3A	0.9300

O—C4	1.403 (8)	C4—H4A	0.9600
C1—C2	1.375 (8)	C4—H4B	0.9600
C1—C3 <sup>i</sup>	1.405 (7)	C4—H4C	0.9600
C2—C3	1.375 (8)		
C1—O—C4	118.1 (5)	C2—C3—H3A	120.1
O—C1—C2	117.4 (5)	C1 <sup>i</sup> —C3—H3A	120.1
O—C1—C3 <sup>i</sup>	124.8 (5)	O—C4—H4A	109.5
C2—C1—C3 <sup>i</sup>	117.8 (5)	O—C4—H4B	109.5
C1—C2—C3	122.5 (5)	H4A—C4—H4B	109.5
C1—C2—Br	118.9 (4)	O—C4—H4C	109.5
C3—C2—Br	118.6 (4)	H4A—C4—H4C	109.5
C2—C3—C1 <sup>i</sup>	119.7 (5)	H4B—C4—H4C	109.5
C4—O—C1—C2	169.3 (5)	O—C1—C2—Br	-1.0 (6)
C4—O—C1—C3 <sup>i</sup>	-11.4 (8)	C3 <sup>i</sup> —C1—C2—Br	179.7 (4)
O—C1—C2—C3	179.8 (5)	C1—C2—C3—C1 <sup>i</sup>	-0.5 (8)
C3 <sup>i</sup> —C1—C2—C3	0.5 (8)	Br—C2—C3—C1 <sup>i</sup>	-179.7 (4)

Symmetry code: (i)  $-x, -y+1, -z+2$ .